

Notice of References Cited	Application/Control No. 10/722,006		Applicant(s)/Patent Under Reexamination CHANG, SEAN	
	Examiner Melissa J Koval		Art Unit 2851	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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X	C	US-6,643,069 B2	11-2003	Dewald, Duane Scott	359/629
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